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			ART UNIT 2117	PAPER NUMBER
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Office Action Summary

Application No.

10/643,549

Applicant(s)

KNEBEL ET AL.

Examiner

Dipakkumar Gandhi

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 13 July 2007.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-28 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-28 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 06 October 2003 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
- ☐ Certified copies of the priority documents have been received.
 - ☐ Certified copies of the priority documents have been received in Application No. _____.
 - ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- ☒ Notice of References Cited (PTO-892)
- ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- ☐ Information Disclosure Statement(s) (PTO/SB/08)
Paper No(s)/Mail Date _____
- ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____
- ☐ Notice of Informal Patent Application
- ☐ Other: _____

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Response to Arguments

1. Applicants' Appeal Brief filed on 07/13/2007 has been entered.
2. Applicants' arguments have been considered but are moot in view of the new ground(s) of rejection.

Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

4. The factual inquiries set forth in *Graham v. John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

1. Determining the scope and contents of the prior art.
2. Ascertaining the differences between the prior art and the claims at issue.
3. Resolving the level of ordinary skill in the pertinent art.
4. Considering objective evidence present in the application indicating obviousness or nonobviousness.

5. Claims 1-8, 20, 23, 24 are rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579) in view of Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1).

As per claim 1, Maguire, Jr. et al. teach determining, at a particular age of the electronic system, one or more performance parameters for the electronic system ("The present invention is a computer-based modeling system designed to improve the overall performance of components and systems that degrade with age. The invention combines expert rules, probabilistic models, and deterministic models to evaluate and predict the effect of component aging on component life extension, operational readiness, maintenance effectiveness, and safety of a system along with evaluating and recommending maintenance and operational actions to improve the overall performance of the modeled system", col. 1, lines 10-19, Maguire, Jr. et al. "The invention reviews the historical data relating to the component or system, evaluates age degradation and extrapolates into the future to develop a life profile including

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measures of life left, useful life, etc. The system predicts the life profile of components or systems by considering several factors including maintenance schedules, subcomponent and part quality, personnel availability, and economic resources. A life profile is an indication of the level of performance of a component or system from its installation to the present and through the expected or predicted out-of-service date", col. 3, lines 28-39, Maguire, Jr. et al.).

However Maguire, Jr. et al. do not explicitly teach the one or more performance parameters correlated with maximum operating frequency of one or more electronic components of the electronic system for the particular age of the electronic system.

Morgan in an analogous art teaches that variations due to, for example, component age, component tolerance, or operating conditions such as temperature, power supply voltage, operating frequency, and humidity, may adversely affect the performance of the feedforward amplifier (col. 2, lines 19-23, Morgan). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Morgan by including an additional step of using the one or more performance parameters correlated with maximum operating frequency of one or more electronic components of the electronic system for the particular age of the electronic system.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to improve the performance of the system by regulating the operating frequency of components.

Maguire, Jr. et al. also do not explicitly teach a method of frequency modification for one or more electronic components in an electronic system, the method comprising the steps of adjusting an operating frequency of the one or more electronic components from the electronic system in accordance with the one or more performance parameters.

However Norman et al. in an analogous art teach that the memory monitors temperature and voltage and adjusts an oscillator circuit to maintain an ideal operating frequency (abstract, Norman et al.). Norman et al. also teach that the control circuitry adjusts the frequency of the clock signal to optimize performance of the flash memory device (col. 21, lines 28-30, Norman et al.). Norman et al. teach adjusting the oscillator in response to the detected dynamic parameter to change the frequency of the clock signal (col. 22, lines

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45-47, Norman et al.). Norman et al. teach that controller coupled...to the output signals (col. 23, lines 9-15, Norman et al.). Norman et al. teach selecting a clock frequency so that the integrated circuit operated at its maximum performance under the monitored environmental operating conditions (col. 24, lines 9-12, Norman et al.).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Norman et al. by including an additional step of using a method of frequency modification for one or more electronic components in an electronic system, the method comprising the steps of adjusting an operating frequency of the one or more electronic components from the electronic system in accordance with the one or more performance parameters.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to optimize performance of the electronic system.

- As per claim 2, Maguire, Jr. et al., Norman et al. and Morgan teach the additional limitations.

Norman et al. teach the method, wherein the step of adjusting adjusts the operating frequency to an adjusted operating frequency, and wherein the adjusted operating frequency is less than or equal to the maximum operating frequency of the one or more electronic components for the particular age of the system (col. 5, lines 45-48, col. 24, lines 9-12, Norman et al.).

- As per claim 3, Maguire, Jr. et al., Norman et al. and Morgan teach the additional limitations.

Norman et al. teach the method, wherein a given one of the one or more performance parameters can be converted to a selected operating frequency to be used in the step of adjusting (col. 21, lines 28-30, col. 22, lines 45-47, Norman et al.).

- As per claim 4, Maguire, Jr. et al., Norman et al. and Morgan teach the additional limitations.

Norman et al. teach the method, wherein the given performance parameter comprises a multiplicand used to convert a base frequency to the selected operating frequency to be used in the step of adjusting (col. 10, lines 39-42, Norman et al.).

- As per claim 5, Maguire, Jr. et al., Norman et al. and Morgan teach the additional limitations.

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Maguire, Jr. et al. teach the step of determining a performance parameter further comprises the steps of determining whether the particular age of the electronic system is a predetermined age and when the particular age is the given age (col. 3, lines 28-32, Maguire, Jr. et al.).

Norman et al. teach determining an operating frequency from the one or more performance parameters (col. 21, lines 28-30, Norman et al.).

- As per claim 6, Maguire, Jr. et al., Norman et al. and Morgan teach the additional limitations.

Norman et al. teach the method, wherein a given one of the one or more performance parameters comprises a predetermined operating frequency to be used in the steps of determining and adjusting (table 5, col. 10, lines 39-42, col. 17, lines 43-55, Norman et al.).

- As per claim 7, Maguire, Jr. et al., Norman et al. and Morgan teach the additional limitations.

Norman et al. teach the method, wherein the step of determining, at a particular age of the electronic system, a performance parameter for the electronic system, further comprises the step of gathering, at the particular age of the electronic system, performance statistics from one or more feedback circuits, and determining whether actual performance of the electronic system should be adjusted by using the performance statistics (col. 22, lines 22-25, Norman et al.).

- As per claim 8, Maguire, Jr. et al., Norman et al. and Morgan teach the additional limitations.

Norman et al. teach the method, wherein the step of gathering, performance statistics from one or more feedback circuits (col. 22, lines 60-61, Norman et al.).

Maguire, Jr. et al. teach the step of gathering, at the particular age of the electronic system, performance statistics from one or more age monitoring circuits (col. 3, lines 20-22, lines 28-32, Maguire, Jr. et al.).

- As per claim 20, Norman et al., Maguire, Jr. et al. and Morgan teach the additional limitations.

Norman et al. teach an electronic system able to perform frequency modification for electronic components, the electronic system comprising: one or more electronic components; at least one clock generation circuit coupled to the one or more electronic components and adapted to adjust an operating frequency of the one or more electronic components from the electronic system in accordance with the one or more performance parameters (abstract, col. 21, lines 28-30, col. 22, lines 45-47, col. 23, lines 9-15, col. 24, lines 9-12, Norman et al.).

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Maguire, Jr. et al. teach to determine, at a particular age of the electronic system, one or more performance parameters for the electronic system (col. 1, lines 10-12, col. 3, lines 20-42, Maguire, Jr. et al.).

Morgan teaches the one or more performance parameters correlated with maximum operating frequency of one or more electronic components of the electronic system for the particular age of the electronic system (col. 2, lines 19-23, Morgan).

- As per claim 23, Norman et al., Maguire, Jr. et al. and Morgan teach the additional limitations.

Norman et al. teach the electronic system, wherein the at least one clock generation circuit further comprises a performance control unit (col. 23, lines 9-15, Norman et al.).

- As per claim 24, Norman et al., Maguire, Jr. et al. and Morgan teach the additional limitations.

Norman et al. teach the electronic system, further comprising one or more feedback circuits in the one or more electronic components, the one or more feedback circuits coupled to the performance control unit (fig. 7A, col. 12, lines 32-35, lines 39-41, Norman et al.).

6. Claims 9, 25 are rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1) as applied to claim 8 above, and further in view of Wu et al. (Bipolar Bootstrapped Multi-emitter BiCMOS (B²M-BiCMOS) Logic for Low-Voltage Applications, Electronics, Circuits, and Systems, 1996, Volume 2, Pages: 1174-1177). As per claim 9, Norman et al., Maguire, Jr. et al. and Morgan substantially teach the claimed invention described in claim 8 (as rejected above).

However Norman et al., Maguire, Jr. et al. and Morgan do not explicitly teach the specific use of the step of determining, at the particular age of the electronic system, a given performance statistic by comparing speed of an aged circuit with speed of a test circuit that is enabled only for the comparison, wherein the aged circuit has been operated for approximately the particular age.

Wu et al. in an analogous art teach to compare speed performance of the new BiCMOS logic circuit with those of CMOS, conventional BiCMOS, and Bootstrapped BiCMOS (BS-BiCMOS) logic circuits (abstract, Wu et al.).

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Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Wu et al. by including an additional step of determining, at the particular age of the electronic system, a given performance statistic by comparing speed of an aged circuit with speed of a test circuit that is enabled only for the comparison, wherein the aged circuit has been operated for approximately the particular age.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to determine if the aged circuit is performing at the same speed as the new circuit.

- As per claim 25, Norman et al., Maguire, Jr. et al., Morgan and Wu et al. teach the additional limitations.

Maguire, Jr. et al. teach that a given one of the one or more performance parameters comprises one or more performance statistics and a given one of the feedback circuits comprises an age-monitoring circuit (col. 3, lines 28-32, lines 36-42, Maguire, Jr. et al.).

Wu et al. teach an aged circuit and a new circuit, wherein the performance control unit is adapted to enable the new circuit only during a comparison between the aged and new circuits and to determine the one or more performance statistics from the comparison, wherein the aged circuit has been operated for approximately the particular age (abstract, Wu et al.).

7. Claim 10 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1) as applied to claim 7 above, and further in view of Chur (US 5,124,849).

As per claim 10, Norman et al., Maguire, Jr. et al. and Morgan substantially teach the claimed invention described in claim 7 (as rejected above).

However Norman et al., Maguire, Jr. et al. and Morgan do not explicitly teach the specific use of the step of gathering, at the particular age of the electronic system, performance statistics from one or more error detecting circuits.

Chur in an analogous art teaches testing of completed head disk assemblies (HDA)...develop into a problem as the HDA ages (col. 15, lines 57-68, Chur).

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Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Chur by including an additional step of gathering, at the particular age of the electronic system, performance statistics from one or more error detecting circuits.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that gathering, at the particular age of the electronic system, performance statistics from one or more error detecting circuits would provide the opportunity to determine the number of errors in the aged circuit operation.

8. Claim 11 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289), Morgan (US 6,525,603 B1) and Chur (US 5,124,849) as applied to claim 10 above, and further in view of Ohie et al. (US 5,936,448).

As per claim 11, Norman et al., Maguire, Jr. et al., Morgan and Chur substantially teach the claimed invention described in claim 10 (as rejected above). Chur also teaches the step of determining that one or more errors have occurred (col. 15, lines 57-68, Chur).

However Norman et al., Maguire, Jr. et al., Morgan and Chur do not explicitly teach the specific use of the steps of lowering operating frequency from a current operating frequency, beginning execution at a point before the one or more errors occurred, determining if the one or more errors reoccur, and if the one or more errors do not reoccur, leaving the lowered operating frequency as the current operating frequency.

Ohie et al. in an analogous art teach that to reduce these measuring errors, the noise supply is decreased by lowering the operating frequency while threshold voltages are measured (col. 1, lines 55-57, Ohie et al.).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Ohie et al. by including an additional step of lowering operating frequency from a current operating frequency, beginning execution at a point before the one or more errors occurred, determining if the one or more errors reoccur, and if the one or more errors do not reoccur, leaving the lowered operating frequency as the current operating frequency.

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This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to reduce the occurrence of errors by lowering the operating frequency.

9. Claim 12 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289), Morgan (US 6,525,603 B1), Chur (US 5,124,849) and Ohie et al. (US 5,936,448) as applied to claim 11 above, and further in view of Burns et al. (US 4,698,587).

As per claim 12, Maguire, Jr. et al., Norman et al., Morgan, Chur and Ohie et al. substantially teach the claimed invention described in claim 11 (as rejected above).

However Maguire, Jr. et al., Norman et al., Morgan, Chur and Ohie et al. do not explicitly teach the specific use of before the step of lowering operating frequency, the steps of beginning execution at a point before the one or more errors occurred, determining if the one or more errors reoccur, and if the one or more errors do not reoccur, leaving current operating frequency alone.

Burns et al. in an analogous art teach determining the maximum operating frequency for which the integrated circuit operates correctly (no logic errors), (col. 8, lines 17-20, Burns et al.).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al's patent with the teachings of Burns et al. by including additionally before the step of lowering operating frequency, the steps of beginning execution at a point before the one or more errors occurred, determining if the one or more errors reoccur, and if the one or more errors do not reoccur, leaving current operating frequency alone.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to determine the maximum operating frequency in an electronic system where no errors occur.

10. Claims 13, 21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1) as applied to claims 1, 20 above, and further in view of Hacker (US 4,845,419).

As per claim 13, Maguire, Jr. et al., Norman et al. and Morgan substantially teach the claimed invention described in claim 1 (as rejected above). Norman et al. also teaches the method wherein the one or more

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performance parameters comprise one or more of previous operating frequency, ambient temperature, and supply voltage (table 5, col. 17, lines 43-55, Norman et al.).

However Maguire, Jr. et al., Norman et al. and Morgan do not explicitly teach that one or more performance parameters comprise hours of operation.

Hacker in an analogous art teaches that the performance of a given type of battery in actual use can be accurately judged since the battery system can itself maintain a count of accumulated hours of use, and other relevant parameters (col. 2, lines 21-24, Hacker). Hacker also teaches that desired parameters...converter (col. 2, lines 49-54, Hacker). Hacker teaches that in a typical use of the portable device...eight to ten hours per day (col. 5, lines 10-14, Hacker).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Hacker by including additionally that one or more performance parameters comprise hours of operation.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to adjust the operating frequency of the components in accordance with the performance parameters.

- As per claim 21, Maguire, Jr. et al., Norman et al., Morgan and Hacker teach the additional limitations.

Norman et al. teach the electronic system, wherein the performance parameters comprise: a corresponding plurality of predetermined operating frequencies; and to adjust operating frequency of the one or more electronic components by adjusting a current operating frequency of the one or more electronic components to a predetermined operating frequency (table 5, col. 17, lines 43-55, Norman et al.).

Maguire, Jr. et al. teach that the performance parameters comprise a plurality of predetermined ages and at a particular age of the electronic system, one or more of the predetermined ages and to determine whether a current age of the electronic system corresponds to a given one of the predetermined ages (col. 3, lines 28-32, Maguire, Jr. et al.).

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Hacker teach that the at least one clock generation circuit comprises a wear-out clock (col. 2, lines 21-24, Hacker).

11. Claims 14-18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1) as applied to claim 1 above, and further in view of Bassett et al. (US 5,127,008).

As per claim 14, Maguire, Jr. et al., Norman et al. and Morgan substantially teach the claimed invention described in claim 1 (as rejected above). Maguire, Jr. et al. also teach the method, wherein the one or more performance parameters are stored performance parameters (col. 3, lines 36-39, Maguire, Jr. et al.).

However Maguire, Jr. et al., Norman et al. and Morgan do not explicitly teach the specific use of performing reliability testing to determine wear-out information.

Basett et al. in an analogous art teach that the second module testing process is performed when it is necessary to enhance the operational reliability of shipped modules, by accelerating and provoking the immediate failure of those correctly but marginally fabricated devices and modules which would otherwise fail early in their expected operational lifespan (col. 1, lines 52-57, Basett et al.).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Norman et al.'s patent with the teachings of Basett et al. by including an additional step of performing reliability testing to determine wear-out information.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that performing reliability testing to determine wear-out information would provide the opportunity to determine the reliability of electronic components.

- As per claim 15, Maguire, Jr. et al., Norman et al., Morgan and Bassett et al. teach the additional limitations.

Maguire, Jr. et al. teach the method, wherein the stored performance parameters comprise predetermined ages (col. 3, lines 28-32, lines 36-39, Maguire, Jr. et al.).

Norman et al. teach predetermined operating frequencies (table 5, col. 17, lines 43-55, Norman et al.).

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- As per claim 16, Maguire, Jr. et al., Norman et al., Morgan and Bassett et al. teach the additional limitations.

Norman et al. teach the step of determining one or more prior operating frequencies of the electronic system, one or more ambient temperatures surrounding the electronic system, and one or more supply voltages of the electronic system (table 5, abstract, col. 3, lines 1-6, col. 17, lines 43-55, Norman et al.).

- As per claim 17, Maguire, Jr. et al., Norman et al., Morgan and Bassett et al. teach the additional limitations.

Bassett et al. teach the method, further comprising the step of providing supply voltage for the electronic system that is higher than nominal supply voltage (col. 1, lines 58-62, Bassett et al.).

- As per claim 18, Maguire, Jr. et al., Norman et al., Morgan and Bassett et al. teach the additional limitations.

Bassett et al. teach the method, further comprising the step of providing ambient temperature surrounding the electronic system that is higher than nominal ambient temperature (col. 1, lines 58-62, Bassett et al.).

12. Claim 19 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1) as applied to claim 1 above, and further in view of Kolanek (US 2002/0047745 A1).

As per claim 19, Maguire, Jr. et al., Norman et al. and Morgan substantially teach the claimed invention described in claim 1 (as rejected above).

However Maguire, Jr. et al., Norman et al. and Morgan do not explicitly teach the specific use of the method, wherein the performance parameters are received from an external source.

Kolanek in an analogous art teaches that the set of desired or set point values for the performance parameters, which are provided to the SLMC 320 from some external source such as a wireless communication network system operator (page 5, paragraph 60, Kolanek).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Kolanek by including an additional step of using the method, wherein the performance parameters are received from an external source.

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This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that using the method, wherein the performance parameters are received from an external source would provide the opportunity to control the performance of the system externally.

13. Claim 22 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289), Morgan (US 6,525,603 B1) and Hacker (US 4,845,419) as applied to claim 21 above, and further in view of Kolanek (US 2002/0047745 A1).

As per claim 22, Maguire, Jr. et al., Norman et al., Morgan and Hacker substantially teach the claimed invention described in claim 21 (as rejected above).

However Maguire, Jr. et al., Norman et al., Morgan and Hacker do not explicitly teach the specific use of the electronic system, wherein the wear-out clock is further adapted to retrieve the predetermined ages and corresponding predetermined operating frequencies from a source external to the wear-out clock.

Kolanek in an analogous art teaches that the set of desired or set point values for the performance parameters, which are provided to the SLMC 320 from some external source such as a wireless communication network system operator (page 5, paragraph 60, Kolanek).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Kolanek by including an additional step of using the electronic system, wherein the wear-out clock is further adapted to retrieve the predetermined ages and corresponding predetermined operating frequencies from a source external to the wear-out clock.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to control the performance of the system externally.

14. Claim 26 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1) as applied to claim 24 above, and further in view of Chur (US 5,124,849) and Ohie et al. (US 5,936,448).

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As per claim 26, Maguire, Jr. et al., Norman et al. and Morgan substantially teach the claimed invention described in claim 24 (as rejected above). Maguire, Jr. et al. also teach the electronic system, wherein a given one of the one or more performance parameters comprises one or more performance statistics (col. 3, lines 36-39, Maguire, Jr. et al.).

However Maguire, Jr. et al., Norman et al. and Morgan do not explicitly teach the specific use of a given one of the feedback circuits comprises an error detecting circuit, the error detecting circuit adapted to determine if an error occurs, wherein the one or more performance statistics indicate than an error has occurred.

Chur in an analogous art teaches testing of completed head disk assemblies (HDA)...develop into a problem as the HDA ages (col. 15, lines 57-68, Chur).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Chur by including an additional step of using a given one of the feedback circuits comprises an error detecting circuit, the error detecting circuit adapted to determine if an error occurs, wherein the one or more performance statistics indicate than an error has occurred.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to determine the number of errors in the aged circuit operation.

Maguire, Jr. et al., Norman et al. and Morgan also do not explicitly teach specifically that the performance control unit is further adapted to receive the one or more performance statistics, indicating that one or more errors have occurred, from the error detection circuit, to lower operating frequency from a current operating frequency, to cause execution to begin at a point before the one or more errors occurred, to determine if the error reoccurs, and if the error does not reoccur, to leave the lowered operating frequency as the current operating frequency.

However Ohie et al. in an analogous art teach that to reduce these measuring errors, the noise supply is decreased by lowering the operating frequency while threshold voltages are measured (col. 1, lines 55-57, Ohie et al.).

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Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Ohie et al. by including additionally that the performance control unit is further adapted to receive the one or more performance statistics, indicating that one or more errors have occurred, from the error detection circuit, to lower operating frequency from a current operating frequency, to cause execution to begin at a point before the one or more errors occurred, to determine if the error reoccurs, and if the error does not reoccur, to leave the lowered operating frequency as the current operating frequency.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to reduce the occurrence of errors by lowering the operating frequency.

15. Claim 27 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579), Norman et al. (US 5,956,289) and Morgan (US 6,525,603 B1) as applied to claim 20 above, and further in view of Iida et al. (US 6,525,585 B1).

As per claim 27, Maguire, Jr. et al., Norman et al. and Morgan substantially teach the claimed invention described in claim 20 (as rejected above).

However Maguire, Jr. et al., Norman et al. and Morgan do not explicitly teach the specific use of the electronic system, wherein the at least one clock generation circuit further comprises an oscillator and one or more frequency multipliers, the oscillator having an output, each of the one or more of the frequency multipliers having an input and output, the output of the oscillator coupled to an input of each of the one or more frequency multipliers, a given one of the one or more electronic components coupled to an output of a given one of the one or more frequency multipliers, and wherein the at least one clock generation circuit is further adapted to create an adjusted operating frequency for the given electronic component by adjusting one or more of the following: operating frequency of the oscillator and a multiplicand used in the given frequency multiplier.

Iida et al. in an analogous art teach that the clock generation circuit... manufacture (fig. 6, col. 3, lines 52-61, Iida et al.).

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Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Iida et al. by including an additional step of using the electronic system, wherein the at least one clock generation circuit further comprises an oscillator and one or more frequency multipliers, the oscillator having an output, each of the one or more of the frequency multipliers having an input and output, the output of the oscillator coupled to an input of each of the one or more frequency multipliers, a given one of the one or more electronic components coupled to an output of a given one of the one or more frequency multipliers, and wherein the at least one clock generation circuit is further adapted to create an adjusted operating frequency for the given electronic component by adjusting one or more of the following: operating frequency of the oscillator and a multiplicand used in the given frequency multiplier.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to adjust the operating frequency of the electronic component to meet the performance requirements.

16. Claim 28 is rejected under 35 U.S.C. 103(a) as being unpatentable over Maguire, Jr. et al. (US 5,331,579) in view of Norman et al. (US 5,956,289), Takahashi (US 6,253,358 B1) and Morgan (US 6,525,603 B1).

As per claim 28, Maguire, Jr. et al. teach determining, at a particular age of the electronic system, one or more performance parameters for the electronic system ("The present invention is a computer-based modeling system designed to improve the overall performance of components and systems that degrade with age. The invention combines expert rules, probabilistic models, and deterministic models to evaluate and predict the effect of component aging on component life extension, operational readiness, maintenance effectiveness, and safety of a system along with evaluating and recommending maintenance and operational actions to improve the overall performance of the modeled system", col. 1, lines 10-19, Maguire, Jr. et al. "The invention reviews the historical data relating to the component or system, evaluates age degradation and extrapolates into the future to develop a life profile including measures of life left, useful life, etc. The system predicts the life profile of components or systems by considering several factors including maintenance schedules, subcomponent and part quality, personnel

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availability, and economic resources. A life profile is an indication of the level of performance of a component or system from its installation to the present and through the expected or predicted out-of-service date", col. 3, lines 28-39, Maguire, Jr. et al.).

However Maguire, Jr. et al. do not explicitly teach the one or more performance parameters correlated with maximum operating frequency of one or more electronic components of the electronic system for the particular age of the electronic system.

Morgan in an analogous art teaches that variations due to, for example, component age, component tolerance, or operating conditions such as temperature, power supply voltage, operating frequency, and humidity, may adversely affect the performance of the feedforward amplifier (col. 2, lines 19-23, Morgan).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Morgan by including an additional step of using the one or more performance parameters correlated with maximum operating frequency of one or more electronic components of the electronic system for the particular age of the electronic system.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to improve the performance of the system by regulating the operating frequency of components.

Maguire, Jr. et al. also do not explicitly teach an article of manufacture for performing frequency modification for electronic components, the article of manufacture comprising: adjusting an operating frequency of the one or more electronic components from the electronic system in accordance with the one or more performance parameters.

However Norman et al. in an analogous art teach that the memory monitors temperature and voltage and adjusts an oscillator circuit to maintain an ideal operating frequency (abstract, Norman et al.). Norman et al. also teach that the control circuitry adjusts the frequency of the clock signal to optimize performance of the flash memory device (col. 21, lines 28-30, Norman et al.). Norman et al. teach adjusting the oscillator in response to the detected dynamic parameter to change the frequency of the clock signal (col. 22, lines 45-47, Norman et al.). Norman et al. teach that controller coupled... to the output signals (col. 23, lines 9-15, Norman et al.). Norman et al. teach selecting a clock frequency so that the integrated circuit operated

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at its maximum performance under the monitored environmental operating conditions (col. 24, lines 9-12, Norman et al.).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Norman et al. by including an additional step of using an article of manufacture for performing frequency modification for electronic components, the article of manufacture comprising: adjusting an operating frequency of the one or more electronic components from the electronic system in accordance with the one or more performance parameters.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that it would provide the opportunity to optimize performance of the article of manufacture.

Maguire, Jr. et al. also do not explicitly teach the specific use of a computer readable medium containing one or more programs which when executed implement the steps.

However Takahashi in an analogous art teaches that a computer-readable medium... perform the steps (col. 18, lines 60-64, Takahashi).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Maguire, Jr. et al.'s patent with the teachings of Takahashi by including an additional step of using a computer readable medium containing one or more programs which when executed implement the steps.

This modification would have been obvious to one of ordinary skill in the art, at the time the invention was made, because one of ordinary skill in the art would have recognized that using a computer readable medium containing one or more programs which when executed implement the steps would provide the opportunity to perform the steps automated, fast and accurately.

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Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dipakkumar Gandhi whose telephone number is 571-272-3822. The examiner can normally be reached on 8:30 AM - 5:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jacques Louis-Jacques can be reached on (571) 272-6962. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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